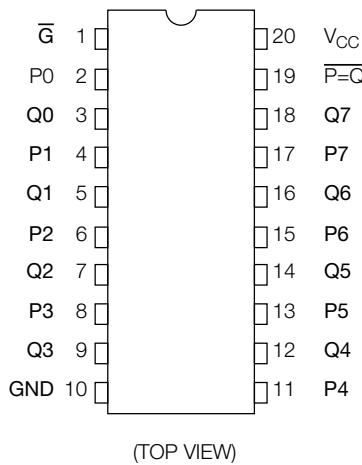


520: with Pull-up Resistor

Features:

- High Speed:** $t_{pd} = 6.4\text{ns}$ (typ.) at $V_{CC} = 5\text{V}$
- Low Power Dissipation:** $I_{CC} = 8\mu\text{A}$ (max.) at $T_a = 25^\circ\text{C}^*$
- High Noise Immunity:** $V_{NIH} = V_{NIL} = 28\% V_{CC}$ (min.)
- Symmetrical Output Impedance:** $|I_{OH}| = |I_{OL}| = 24\text{mA}$ (min.). Capability of driving 50Ω transmission lines.
- Balanced Propagation Delays:** $t_{pLH} = t_{pHL}$
- Wide Operating Voltage Range:** V_{CC} (opr) = $2\text{V} \sim 5.5\text{V}$
- Pin and Function Compatible with 74F521**
- Available in DIP, SOIC and SOP Packages**

* for AC521 only

Pin Assignment**Truth Table**

INPUTS		OUTPUT
P, Q	\bar{G}	$\bar{P} = \bar{Q}$
P = Q	L	L
P ≠ Q	L	H
X	H	H

X: Don't Care

The TC74AC520 and TC74AC521 are advanced high speed CMOS 8-BIT DIGITAL COMPARATORS fabricated with silicon gate and double-layer metal wiring C²MOS technology.

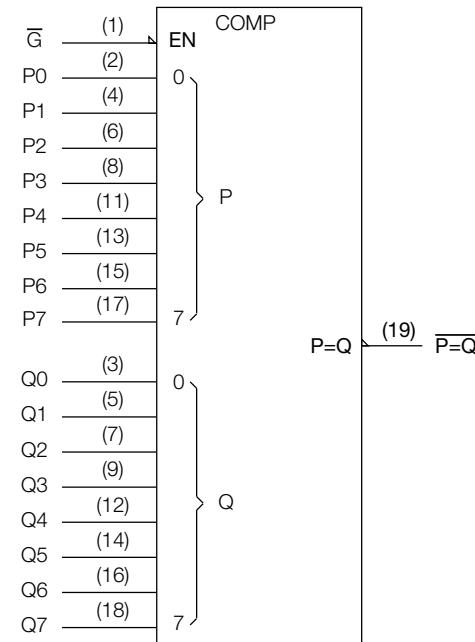
They achieve the high speed operation similar to equivalent Bipolar Schottky TTL, while maintaining the CMOS low power dissipation.

They compare two 8-bit binary or BCD words applied inputs P0~P7, and inputs Q0~Q7, and indicate whether or not they are equal.

The TC74AC520 is equipped with pull-up resistors (20Ω typ.) to inputs Q0~Q7 and features pull-up resistors on the Q inputs for switch data.

A signal active low enable is provided to facilitate cascading of several packages to compare words greater than 8 bits.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

IEC Logic Symbol

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Absolute Maximum Ratings

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	V_{CC}	-0.5~7.0	V
DC Input Voltage	V_{IN}	-0.5~ V_{CC} + 0.5	V
DC Output Voltage	V_{OUT}	-0.5~ V_{CC} + 0.5	V
Input Diode Current	I_{IK}	± 20	mA
Output Diode Current	I_{OK}	± 50	mA
DC Output Current	I_{OUT}	± 50	mA
DC V_{CC} /Ground Current	I_{CC}	± 100	mA
Power Dissipation	P_D	500 (DIP) */180 (SOP)	mW
Storage Temperature	T_{stg}	-65~150	°C
Lead Temperature 10sec	T_L	300	°C

* 500mW in the range of $T_a = -40\text{°C} \sim 65\text{°C}$.
From $T_a = 65\text{°C}$ to 85°C a derating factor of -10mW/°C should be applied up to 300mW.

Recommended Operating Conditions

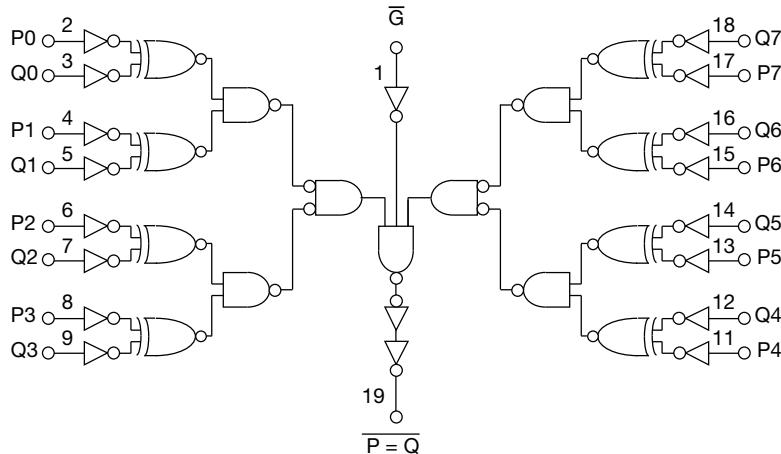
PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	V_{CC}	2.0~5.5	V
Input Voltage	V_{IN}	0~ V_{CC}	V
Output Voltage	V_{OUT}	0~ V_{CC}	V
Operating Temperature	T_{opr}	-40~85	°C
Input Rise and Fall Time	dt/dv	0~100 ($V_{CC} = 3.3 \pm 0.3\text{V}$) 0~20 ($V_{CC} = 5 \pm 0.5\text{V}$)	ns/v

DC Electrical Characteristics

PARAMETER	SYMBOL	TEST CONDITION	$T_a = 25\text{°C}$			$T_a = -40\text{~}85\text{°C}$		UNIT		
			V_{CC}	Min.	Typ.	Max.	Min.			
High-Level Input Voltage	V_{IH}	—	2.0	1.50	—	—	1.50	—	V	
			3.0	2.10	—	—	2.10	—		
			5.5	3.85	—	—	3.85	—		
Low-Level Input Voltage	V_{IL}	—	2.0	—	—	0.50	—	0.50	V	
			3.0	—	—	0.90	—	0.90		
			5.5	—	—	1.65	—	1.65		
High-Level Output Voltage	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -50\mu\text{A}$	2.0	1.9	2.0	—	1.9	V	
				3.0	2.9	3.0	—	2.9		
				4.5	4.4	4.5	—	4.4		
			$I_{OH} = -4\text{mA}$	3.0	2.58	—	—	2.48		
			$I_{OH} = -24\text{mA}$	4.5	3.94	—	—	3.80		
			$I_{OH} = -75\text{mA}^*$	5.5	—	—	—	3.85		
			$I_{OL} = 50\mu\text{A}$	2.0	—	0.0	0.1	—	V	
Low-Level Output Voltage	V_{OL}	$V_{IN} = V_{IH}$ or V_{IL}		3.0	—	0.0	0.1	—		
				4.5	—	0.0	0.1	—		
				3.0	—	—	0.36	—		
				4.5	—	—	0.36	—		
				5.5	—	—	—	—		

* This spec indicates the capability of driving 50Ω transmission lines.
One output should be tested at a time for a 10ms maximum duration.

System Diagram



Note: AC520 is equipped with pull-up resistors (20k Ω typ.) to inputs Q₀ ~ Q₇.

DC Electrical Characteristics

i) AC520

PARAMETER	SYMBOL	TEST CONDITION	Ta = 25°C			Ta = -40~85°C		UNIT
			V _{CC}	Min.	Typ.	Max.	Min.	
Input Leakage Current	I _{IN}	P and \bar{G} inputs only $V_{IN} = V_{CC}$ or GND	5.5	—	—	± 1.0	—	± 1.0
High-Level Input Current	I _{IH}	Q inputs only $V_{IN} = V_{CC}$	5.5	—	—	10	—	10
Low-Level Input Current	I _{IL}	Q inputs only $V_{IN} = \text{GND}$	5.5	—	-0.3	-0.6	—	-1.0
Quiescent Supply Current	I _{CC}	Q inputs open P and \bar{G} inputs, $V_{IN} = V_{CC}$ or GND	5.5	—	—	8.0	—	80.0
		Q inputs, $V_{IN} = \text{GND}$ P and \bar{G} inputs, $V_{IN} = V_{CC}$ or GND	5.5	—	—	4.8	—	8.0
								mA

ii) AC521

PARAMETER	SYMBOL	TEST CONDITION	Ta = 25°C			Ta = -40~85°C		UNIT
			V _{CC}	Min.	Typ.	Max.	Min.	
Input Leakage Current	I _{IN}	$V_{IN} = V_{CC}$ or GND	5.5	—	—	± 0.1	—	± 1.0
Quiescent Supply Current	I _{CC}	$V_{IN} = V_{CC}$ or GND	5.5	—	—	8.0	—	80.0

AC Electrical Characteristics ($C_L = 50\text{pF}$, $R_L = 500\Omega$, Input $t_r = t_f = 3\text{ns}$)

PARAMETER	SYMBOL	TEST CONDITION	Ta = 25°C			Ta = -40~85°C		UNIT
			V _{CC}	Min.	Typ.	Max.	Min.	
Propagation Delay Time (P _n , Q _n –P=Q)	t _{pLH}	—	3.0±0.3	—	10.5	17.5	1.0	20.0
	t _{pHL}		5.0±0.5	—	7.2	11.0	1.0	12.5
Propagation Delay Time (G–P=Q)	t _{pLH}	—	3.0±0.3	—	7.2	11.5	1.0	13.0
	t _{pHL}		5.0±0.5	—	4.8	7.0	1.0	8.0
Input Capacitance	C _{IN}	—	—	—	5	10	—	10
Power Dissipation Capacitance	C _{PD} ¹	—	—	—	34	—	—	pF

Note (1): C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.
Average operating current can be obtained by the equation: I_{CC (opr)} = C_{PD} • V_{CC} • f_{IN} + I_{CC}.